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# Bilateral comparison between EIM and IMBiH in DC Voltage
# Calibration of a Zener DC voltage standard of 10 V

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# 1.   INTRODUCTION

The present intercomparison was proposed by the Institute of Metrology of Bosnia and Herzegovina (IMBiH), with the motive of supporting its CMCs in the quantity of Voltage. The Hellenic Institute of Metrology (EIM) and the laboratory of Low Frequency of the Electrical Measurements Department was the pilot of the intercomparison and the travelling standard was provided by IMBiH.

The steps for the transport of the standard, the timetable of measurements and the reporting formulations were described in the protocol of the intercomparison, which was prepared following the CCEM guidelines.

# 2.   DETAILS

## 2.1  Participants

The Pilot laboratory was the Low Frequency laboratory of the Hellenic Institute of Metrology:

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The participating laboratory was IMBiH:

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*Laboratory for electrical quantities and T&F*
*Augusta Brauna 2*
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*Bosnia and Herzegovina*
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## 2.2  Timetable

The measurements were performed according to the following timetable:

**Time table of the Measurments**

| Institute | Action | Time period |
|-----------|--------|-------------|
| IMBiH | Perform IMBiH measurements | 1-10 July 2015 |
| EIM | Perform EIM measurements | 27-31 July 2015 |
| IMBiH | Perform IMBiH measurements | 12-21 August 2015 |

## 2.3 Travelling standard

The travelling standard was a voltage standard of the Zener type provided by IMBiH. The measured voltage was the 10 V output of the Zener and the measurements were performed by the two institutes, EIM and IMBiH minimizing the time interval between them. Its transport was done with the external battery of the Zener connected to it. The "INCAL" led of the Zener was always ON throughout the intercomparison.

The travelling standard had the following characteristics:

DC Reference standard

Device:           Zener
Nominal value:    10 Volt
Manufacturer:     Fluke
Type:             732B
Serial Number:    2231035

External battery:   Fluke 732B-7001
Serial number:   221002

## 3.    MEASUREMENTS

### 3.1  Methods of measurement

The participating laboratory described the method of measurement and the environmental conditions within its report, as it was requested in the protocol of the comparison. The calibration was performed as follows:

The measurements were made using a System for calibration DC voltage Reference Standards.
The system for calibration DC voltage Reference Standard consist: 4 zener cells, Low Thermal Scanner (32 channels), nanovoltmeter Keithly 2182A and PC with program VoltRef.

The unknown DC voltage Reference Standard placed in system for calibration DC voltage with three known DC Reference Standards. All DC voltage Reference Standard must be disconnect from power during calibration. For three known DC Reference Standards indication light "INCAL" must be ON. For the estimation of the reproducibility, the measurement must be repeated at least five different days. Value of unknown DC voltage Reference Standard is defined as mean value of values determined by comparison with three known DC Reference Standards

The pilot laboratory used the method of comparing the travelling standard with the primary Josephson voltage standard of EIM. The measurement system was manufactured by Hypres Inc. (USA) and comprised of:

- Josephson array of SIS type
- Helium dewar 120 lit
- Microwave gun system 74-76 GHz
- Counter EIP 578B
- Nanovoltmeter of type HP34420A

For the automation of the measurements the NISTVOLT software for windows prepared by NIST was used.

## 3.2  IMBiH Results

IMBiH performed the measurements at two times, one before and one after the measurements of the pilot lab. Its results were the following:

**IMBiH RESULTS 10 V**

| Date of measurement | Temperature | Humidity | Measurement result | Stdev |
|---|---|---|---|---|
| 01.07.2015 | 23.34 | 48.94 | 10.000 074 55 | 5.18E-09 |
| 02.07.2015 | 23.12 | 49.32 | 10.000 073 53 | 4.03E-09 |
| 03.07.2015 | 22.74 | 50.67 | 10.000 074 39 | 5.03E-09 |
| 06.07.2015 | 22.76 | 50.89 | 10.000 075 14 | 5.01E-09 |
| 07.07.2015 | 22.75 | 51.38 | 10.000 072 56 | 3.82E-09 |
| 08.07.2015 | 22.83 | 49.73 | 10.000 076 03 | 5.02E-09 |
| 09.07.2015 | 22.89 | 50.20 | 10.000 075 75 | 4.88E-09 |
| 10.07.2015 | 22.82 | 46.50 | 10.000 073 54 | 4.40E-09 |
| (EIM Measurements) | | | | |
| 12.08.2015 | 23.04 | 45.08 | 10.000 075 21 | 5.95E-09 |
| 13.08.2015 | 22.91 | 44.24 | 10.000 073 34 | 4.17E-09 |
| 14.08.2015 | 22.90 | 44.90 | 10.000 073 58 | 8.25E-09 |
| 17.08.2015 | 22.69 | 51.00 | 10.000 074 24 | 3.49E-09 |
| 18.08.2015 | 22.68 | 50.01 | 10.000 074 41 | 4.22E-09 |
| 19.08.2015 | 22.78 | 47.01 | 10.000 074 54 | 4.10E-09 |
| 20.08.2015 | 22.84 | 48.92 | 10.000 073 96 | 4.42E-09 |
| 21.08.2015 | 22.74 | 48.35 | 10.000 075 52 | 5.61E-09 |

In the following graphs the results of MBiH are presented as a function of the date.
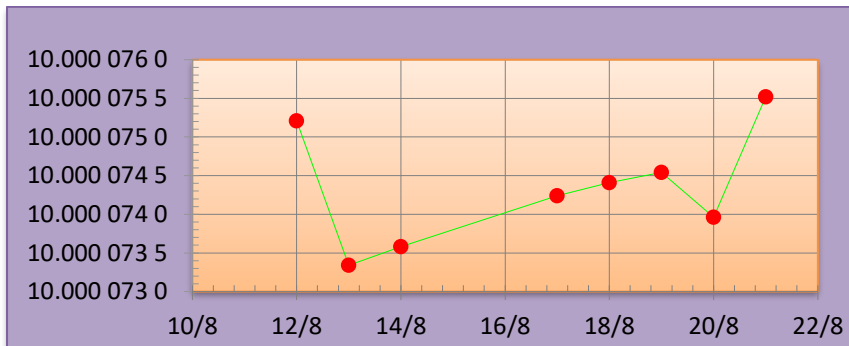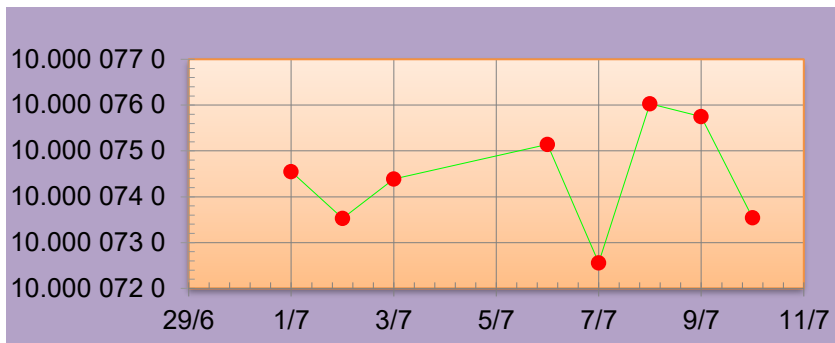
The reported result of IMBiH is the following:

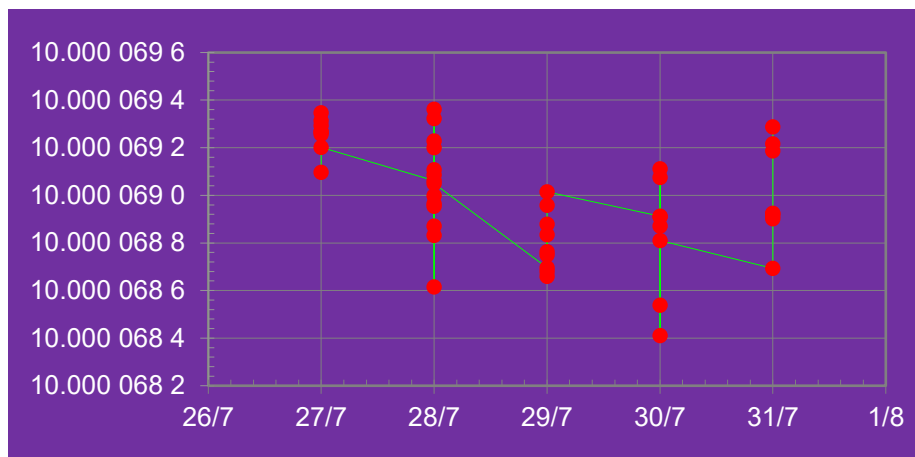| Date | Voltage (V) | uc (V) | $U$ ($k$=2) (V) |
|---|---|---|---|
| Reported by IMBiH | | | |
| 7/7/2015 | 10. 000 074 436 | 0.000 018 | 0.000 035 |
| 15/8/2015 | 10. 000 074 350 | 0.000 018 | 0.000 035 |

### 3.3  EIM Reference value

EIM performed measurements of the Zener once, between the two measurements of IMBiH. In total 50 measurements of the Zener standard compared to the Josephson standard were taken.

**EIM MEASUREMENTS**

| Date | Time | Meas. Voltage (V) | $u_c$ (nV) |
|---|---|---|---|
| 27 July 2015 | 10:30 | 10.0000691 | 45 |
| 27 July 2015 | 10:37 | 10.00006931 | 37 |
| 27 July 2015 | 10:44 | 10.00006935 | 27 |
| 27 July 2015 | 10:52 | 10.00006926 | 28 |
| 27 July 2015 | 14:46 | 10.00006929 | 43 |
| 27 July 2015 | 14:54 | 10.00006927 | 29 |
| 27 July 2015 | 15:02 | 10.00006927 | 27 |
| 27 July 2015 | 15:11 | 10.0000692 | 30 |
| 28 July 2015 | 10:53 | 10.00006906 | 32 |
| 28 July 2015 | 11:00 | 10.00006911 | 27 |
| 28 July 2015 | 11:07 | 10.00006897 | 30 |
| 28 July 2015 | 11:15 | 10.00006862 | 33 |

| | | | |
|---|---|---|---|
| 28 July 2015 | 11:25 | 10.0000692 | 28 |
| 28 July 2015 | 11:37 | 10.00006923 | 29 |
| 28 July 2015 | 11:44 | 10.00006936 | 27 |
| 28 July 2015 | 11:52 | 10.00006932 | 28 |
| 28 July 2015 | 14:53 | 10.00006883 | 28 |
| 28 July 2015 | 15:00 | 10.00006895 | 30 |
| 28 July 2015 | 15:08 | 10.000069 | 26 |
| 28 July 2015 | 15:18 | 10.00006887 | 32 |
| 28 July 2015 | 15:25 | 10.00006909 | 28 |
| 28 July 2015 | 15:34 | 10.00006905 | 30 |
| 29 July 2015 | 09:50 | 10.0000687 | 34 |
| 29 July 2015 | 09:57 | 10.00006875 | 29 |
| 29 July 2015 | 10:04 | 10.00006866 | 38 |
| 29 July 2015 | 12:50 | 10.00006883 | 29 |
| 29 July 2015 | 12:57 | 10.00006888 | 28 |
| 29 July 2015 | 13:04 | 10.00006868 | 55 |
| 29 July 2015 | 14:32 | 10.00006876 | 29 |
| 29 July 2015 | 14:39 | 10.00006896 | 28 |
| 29 July 2015 | 14:46 | 10.00006902 | 33 |
| 30 July 2015 | 10:43 | 10.00006891 | 29 |
| 30 July 2015 | 10:51 | 10.00006891 | 28 |
| 30 July 2015 | 10:58 | 10.00006908 | 31 |
| 30 July 2015 | 11:05 | 10.00006911 | 33 |
| 30 July 2015 | 14:12 | 10.00006887 | 33 |
| 30 July 2015 | 14:19 | 10.00006854 | 35 |
| 30 July 2015 | 14:27 | 10.00006841 | 38 |
| 30 July 2015 | 14:34 | 10.00006881 | 59 |
| 31 July 2015 | 10:09 | 10.00006869 | 27 |
| 31 July 2015 | 10:17 | 10.00006892 | 34 |
| 31 July 2015 | 10:24 | 10.00006893 | 31 |
| 31 July 2015 | 10:31 | 10.0000689 | 30 |
| 31 July 2015 | 12:47 | 10.00006891 | 29 |
| 31 July 2015 | 12:54 | 10.00006922 | 31 |
| 31 July 2015 | 13:00 | 10.00006919 | 32 |
| 31 July 2015 | 13:08 | 10.00006929 | 33 |
| 31 July 2015 | 14:02 | 10.00006905 | 27 |
| 31 July 2015 | 14:09 | 10.00006908 | 28 |
| 31 July 2015 | 14:16 | 10.0000689 | 43 |
| 31 July 2015 | 14:23 | 10.00006901 | 32 |

A graph of EIM's measurements is presented below. The reference value of the intercomparison is calculated as the average of the above values and the reference date is considered as the mean date of the measurements.

## EIM 10 V Reference value

| Date | Zener Voltage (V) | uc (V) | $U$ ($k$=2) (V) |
|---|---|---|---|
| 29 July 2015 | 10.000 068 993 | 0.000 000 47 | 0.000 000 93 |

## 4.  UNCERTAINTY

The uncertainty of the measurements was calculated by both laboratories according to the international standards ISO "Guide to the Expression of Uncertainty in Measurement", 1995 and the standard EA-4/02. The uncertainty budget of IMBiH is presented in the Appendix.
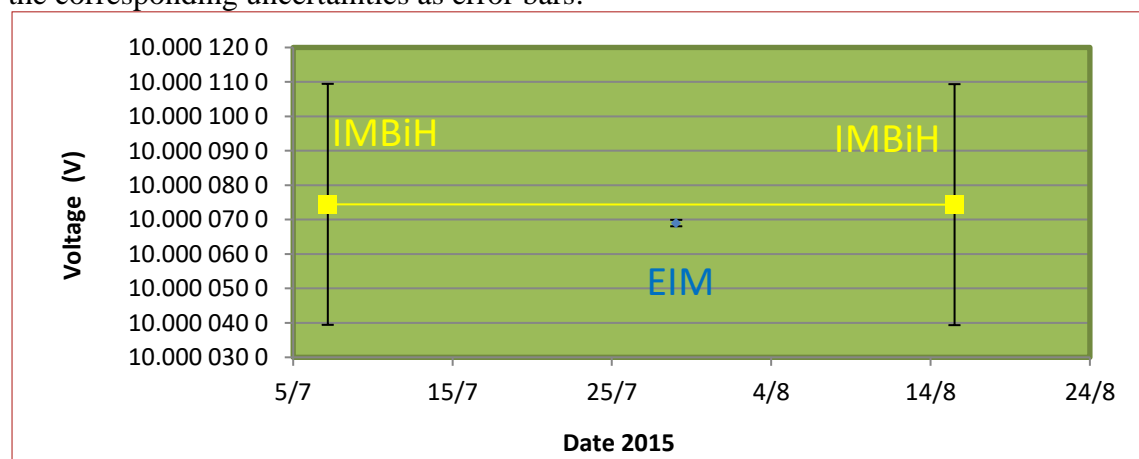
### 4.1  Expanded Uncertainty

The expanded uncertainty for a level of confidence of 95% is given by the relation:

$U$=1,96 $u$

Where u is the combined standard uncertainty.

## 5.  EVALUATION OF THE RESULTS

In the next graph the results of the participating laboratory and the pilot laboratory are presented with the corresponding uncertainties as error bars.

## 5.1    IMBiH at the Reference Date

A linear regression between the two IMBiH measurements gives the a, b constants of the line connecting the two measurements, i.e. intersection and slope. Using the constants a and b the value of the zener voltage at the chronological point of the EIM measurements can be computed. This will be compared directly with the reference value of EIM calculated before. The results of the calculation are presented below:

| IMBiH value at the Reference Date | | | | |
|---|---|---|---|---|
| **Reference Date** | **Resistance (Ω)** | **$U$ ($k$=2) (V)** | a= | -2.193E-09 V/day |
| 29 July 2015 | 10.000 074 388 | 0.000 035 | b= | 10.000 074 44 V |
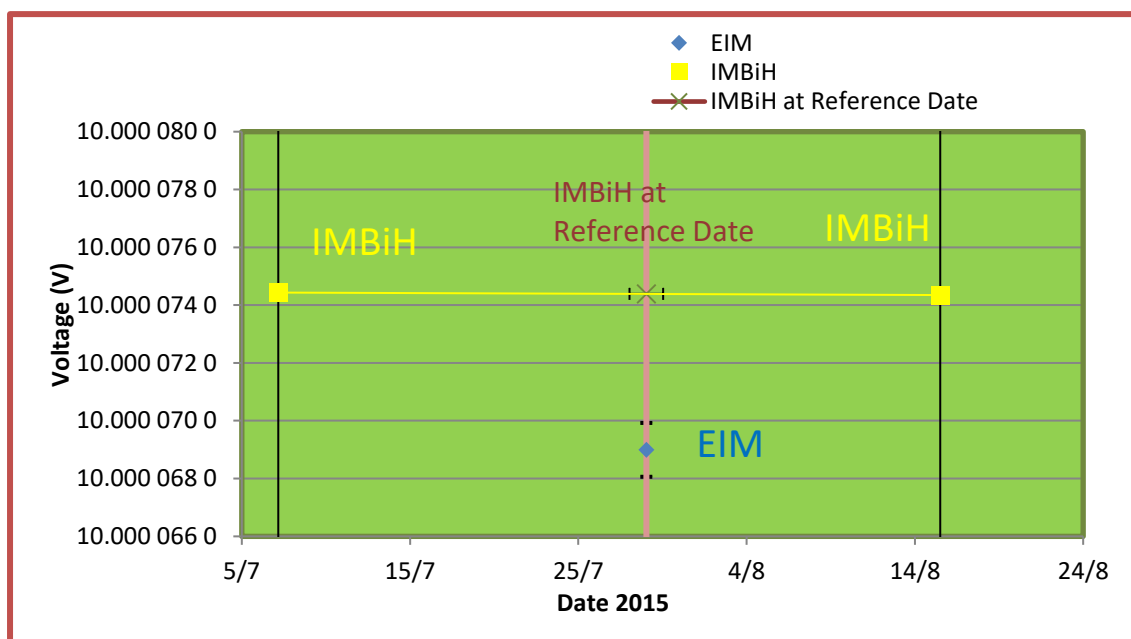


## 5.2    Comparison IMBiH-EIM

Having computed the value of IMBiH corresponding to the reference date, the difference with the pilot lab result can be computed directly.

**Comparison EIM-IMBiH**

| Nominal Voltage | IMBiH-EIM Difference (μV) | IMBiH-EIM Difference (ppm) | Expanded Uncertainty $U$ ($k$=2) (μV) |
|---|---|---|---|
| 10 V | 5.4 | 0.54 | 89.1 |

### 5.3  Index $E_n$

According to the directive EA-2/03 "Interlaboratry Comparisons", the evaluation of the measurement results is performed with the estimation of the parameter $E_n$, which is defined as:

$$E_n = \frac{V_{LAB} - V_{EIM}}{\sqrt{U^2(V_{LAB}) + U^2(V_{EIM})}} \quad \text{where,}$$

$V_{LAB}$ is the error measured by the participating lab

$V_{EIM}$ is the error measured by the pilot lab

$U(V_{LAB})$ is the expanded uncertainty of the participating lab and

$U(V_{EIM})$ is the expanded uncertainty of the pilot lab.

All the values of En are expected to be less than unity: $|E_n| < 1$.

In the next table all the values of En are presented for the participating laboratory.

#### *En* values of the intercomparison

| Nominal value | *En* |
|:---:|:---:|
| 10 V | -0.14 |

### 5.4  Conclusion

The value of the index En is less than unity in absolute value $|En| < 1$ as it is expected.

APPENDIX

IMBiH Uncertainty Budget

**10 V Uncertainty Budget IMBiH**

| Quantity $X_i$ | Estimate $x_i$ | Relative standard uncertainty $u(x_i)$ | Probability distribution / method of evaluation (A, B) | Sensitivity coefficient $c_i$ | Relative uncertainty contribution $u(R_i)$ | Degree of freedomn $v_i$ |
|---|---|---|---|---|---|---|
| UUT value of zener $V_x$ | 10.000 074 | 0.002 | Normal | 1 | 1.62E-09 | 383 |
| Calibration $V_s$ (Certificate) $V_{cert}$ | 0 | 0.25 | Normal | 1 | 2.50E-06 | ∞ |
| Drift $V_s$, 3 year $V_{drift}$ | 0 | 1.73 | Rectangular | 1 | 1.73E-05 | ∞ |
| Temp. Coeff. Vtemp | 0 | 0.023 | Rectangular | 1 | 2.31E-07 | ∞ |
| Nanovoltmeter resolution $V_{res}$ | 0 | 0.03 | Rectangular | 1 | 2.89E-07 | ∞ |
| Nanovoltmeter specification $V_{spec}$ | 0 | 0.026 | Rectangular | 1 | 2.60E-08 | ∞ |
| $R_x$ | 10.000 074 | | | | | |
| | | Combined standard uncertainty: | | | | 0.000018 |
| | | Degrees of freedom: | | | | 5.19E+18 |
| | | Expanded uncertainty (coverage factor 95% ): | | | | 0.000035 |